

CHIP COIL (CHIP INDUCTORS) LQP03TN□□□□02D REFERENCE SPECIFICATION

1.Scope

This reference specification applies to LQP03TN_02 series, Chip coil (Chip Inductors).

2.Part Numbering

(ex)	LQ	<u> </u>	03	T	N	0N6	B	0	2	D
	Product ID	Structure	e Dimensi	on Applications	Category	Inductance	Tolerance	Features	Electrode	Packaging
			$(L \times W)$	and						D:Taping
				Characteristics	S					*B:Bulk

*Bulk packing also available. (A product is put in the plastic bag under the taping conditions.)

3.Rating

•Operating Temperature Range. −55°C to +125°C

(Ambient temperature: Rated current can be handled in this temperature range.)

•Storage Temperature Range. -55°C to +125°C

Customer Part Number			uctance	Q	DC Resistance	Self Reso Frequ	iency	Rated Current					
Fait Number	rait Number	(nH)	Tolerance	Tolerance (min)		(MHz) Min. *Tvp.		(mA)					
	LQP03TN0N6B02D					IVIII I.	*Тур.						
	LQP03TN0N6C02D	0.6			0.07			850					
	LQP03TN0N7B02D		1			20000							
	LQP03TN0N7C02D	0.7											
	LQP03TN0N8B02D				0.08			800					
	LQP03TN0N8C02D	0.8											
	LQP03TN0N9B02D					18000							
	LQP03TN0N9C02D	0.9											
	LQP03TN1N0B02D		1				20000						
	LQP03TN1N0C02D	1.0											
	LQP03TN1N1B02D		1		0.10			750					
	LQP03TN1N1C02D	1.1			 	17000							
	LQP03TN1N2B02D						17000	17000	17000	17000	1/000		
	LQP03TN1N2C02D	1.2											
	LQP03TN1N3B02D												
	LQP03TN1N3C02D	1.3											
	LQP03TN1N4B02D		1			40000	40000						
	LQP03TN1N4C02D	1.4				16000	19600						
	LQP03TN1N5B02D		B:±0.1nH	14			47000						
	LQP03TN1N5C02D	1.5	C:±0.2nH				17900						
	LQP03TN1N6B02D		1				20000						
	LQP03TN1N6C02D	1.6				0.15	20000						
	LQP03TN1N7B02D		1		0.15		10100	7					
	LQP03TN1N7C02D	1.7					19100	000					
	LQP03TN1N8B02D						17700	600					
	LQP03TN1N8C02D	1.8]				17700						
	LQP03TN1N9B02D	_					15100						
	LQP03TN1N9C02D	1.9]			12500	15100						
	LQP03TN2N0B02D	_				12300	14800						
	LQP03TN2N0C02D	2.0					17000						
	LQP03TN2N1B02D	2.1				13900							
	LQP03TN2N1C02D		_			11000	10300						
	LQP03TN2N2B02D	0.0	2.2			11000	13400						
	LQP03TN2N2C02D	2.2					.0.00						
	LQP03TN2N3B02D	0.0				12900							
	LQP03TN2N3C02D	2.3			0.00	10000		500					
	LQP03TN2N4B02D	0.4			0.20	10000	12200	500					
	LQP03TN2N4C02D	2.4	2.4										

Customer Part Number	MURATA Part Number	Inductance		Q (min)	DC Resistance (Ω max)	Self Resonant Frequency (MHz)		Rated Current
		(nH)	Tolerance	(******)	(32 IIIax)	Min.	*Typ.	(mA)
	LQP03TN2N5B02D						12200	
	LQP03TN2N5C02D	2.5					12200	
	LQP03TN2N6B02D					10000	13300	
	LQP03TN2N6C02D	2.6				10000	13300	
	LQP03TN2N7B02D	0.7			0.20		13000	500
	LQP03TN2N7C02D	2.7			5.25		.0000	500
	LQP03TN2N8B02D	2.8					11800	
	LQP03TN2N8C02D	2.0						-
	LQP03TN2N9B02D LQP03TN2N9C02D	2.9				9500	12400	
	LQP03TN2N9C02D LQP03TN3N0B02D	2.0						
	LQP03TN3N0C02D	3.0					11900	
	LQP03TN3N1B02D		1					
	LQP03TN3N1C02D	3.1					11300	
	LQP03TN3N2B02D							
	LQP03TN3N2C02D	3.2				8000	10600	
	LQP03TN3N3B02D				0.25		40000	450
	LQP03TN3N3C02D	3.3	B:±0.1nH				10900	
	LQP03TN3N4B02D		C:±0.2nH				0400	
	LQP03TN3N4C02D	3.4				7000	9400	
	LQP03TN3N5B02D						9600	
	LQP03TN3N5C02D	3.5					3000	
	LQP03TN3N6B02D	3.6	_				9500	
	LQP03TN3N6C02D							
	LQP03TN3N7B02D	0.7				6000	8200	400
	LQP03TN3N7C02D	3.7			0.30	5700		
	LQP03TN3N8B02D	3.8		14			8100	
	LQP03TN3N8C02D	5.0		14				
	LQP03TN3N9B02D LQP03TN3N9C02D	3.9					7900	
	LQP03TN4N0B02D	0.0						
	LQP03TN4N0C02D	4.0				5300	8600	350
	LQP03TN4N1B02D							
	LQP03TN4N1C02D	4.1					8400	
	LQP03TN4N2B02D						0000	
	LQP03TN4N2C02D	4.2					8600	
	LQP03TN4N3H02D						0000	
	LQP03TN4N3J02D	4.3			0.40		9800	
	LQP03TN4N7H02D	. –				4400	8800	
	LQP03TN4N7J02D	4.7				7700	5500	
	LQP03TN5N1H02D	<i>-</i> 4				4200	8600	
	LQP03TN5N1J02D	5.1					3000	-
	LQP03TN5N6H02D	5.6					8000	
	LQP03TN5N6J02D	0.0	U 004			4000		
	LQP03TN6N2H02D	6.2	H:±3%				7900	
	LQP03TN6N2J02D LQP03TN6N8H02D	0.2	J:±5%					-
	LQP03TN6N8J02D	6.8			0.60	3900	8000	300
	LQP03TN7N5H02D							300
	LQP03TN7N5J02D	7.5				3700	6700	
	LQP03TN8N2H02D		1			0000	0000	
	LQP03TN8N2H02D 8.2				3600	6600		
	LQP03TN9N1H02D		1		0.70	2202	E000	250
	LQP03TN9N1J02D	9.1				3300	5900	

Customer Part Number	MURATA Part Number	Inductance		Q	DC Resistance	Self Resor Frequ	iency Current		
i ait ivuilibei	i ait ivuilibei	(nH)	Tolerance	(min)	(Ω max)	Min.	Hz) *Typ.	(mA)	
	LQP03TN10NH02D	40			0.70				
	LQP03TN10NJ02D	10		4.4	0.70	3200	5800		
	LQP03TN11NH02D	4.4	1	14			F400		
	LQP03TN11NJ02D	11			0.80	2000	5400		
	LQP03TN12NH02D	40				2900			
	LQP03TN12NJ02D	12			0.70		4200	250	
	LQP03TN13NH02D	40	1				4300		
	LQP03TN13NJ02D	13			0.80	2600			
	LQP03TN15NH02D	15				2000	3800		
	LQP03TN15NJ02D	10			0.70		3600		
	LQP03TN16NH02D	16					3700		
	LQP03TN16NJ02D	10			0.95		3700		
	LQP03TN18NH02D	10					3400	200	
	LQP03TN18NJ02D	18		12	0.80	2200	3400		
	LQP03TN20NH02D	20				2200	3600		
	LQP03TN20NJ02D	20			2.30		3000		
	LQP03TN22NH02D	22					3300	150	
	LQP03TN22NJ02D	2D 22		1.90		3300			
	LQP03TN24NH02D	24					3200		
	LQP03TN24NJ02D	24				2000	3200	140	
	LQP03TN27NH02D	27			2.30		2900		
	LQP03TN27NJ02D	21					2900		
	LQP03TN30NH02D	30					2700		
	LQP03TN30NJ02D	33	H:±3% J:±5%			1700	2700	120	
	LQP03TN33NH02D				2.95	1700	2600		
	LQP03TN33NJ02D						2000		
	LQP03TN36NH02D				3.00 1500		2400	120	
	LQP03TN36NJ02D	30				1500	2200	-	
	LQP03TN39NH02D	39				1300			
	LQP03TN39NJ02D	39		_					
	LQP03TN43NH02D	43		9			2200		
	LQP03TN43NJ02D	+0				1300			
	LQP03TN47NH02D	47			3.60	1300			
	LQP03TN47NJ02D								
	LQP03TN51NH02D	51					2000		
	LQP03TN51NJ02D	J 1			0.00	1200	2000		
	LQP03TN56NH02D	56			3.90	.200			
	LQP03TN56NJ02D							400	
	LQP03TN62NH02D	62					1800	100	
	LQP03TN62NJ02D	~-			0	1100	1000		
	LQP03TN68NH02D	68			8		1500		
	LQP03TN68NJ02D								
	LQP03TN75NJ02D	75 82 91 100							
	LQP03TN75NH02D					1000	1400		
	LQP03TN82NH02D					-			
	LQP03TN82NJ02D			8	10				
	LQP03TN91NH02D			0	10				
	LQP03TN91NJ02D					900	1300		
	LQP03TNR10H02D							90	
	LQP03TNR10J02D								
	LQP03TNR11H02D	110						80	
	LQP03TNR11J02D				12	800	1100		
	LQP03TNR12H02D	120			14				
	LQP03TNR12J02D	120		<u> </u>					

Customer Part Number	MURATA Part Number	Inductance		Q (min)	DC Resistance	Self Resonant Frequency		Rated Current
T dit (valido)	T dit (Valliso)	(nH)	Tolerance	(min)	(Ω max)	(Mi Min.	Hz) *Typ.	(mA)
	LQP03TNR13H02D	130		5	9		960	
	LQP03TNR13J02D	130				650	960	
	LQP03TNR15H02D	150 160 180	H:±3% J:±5%			030	880	80
	LQP03TNR15J02D						000	
	LQP03TNR16H02D				11	600	840	
	LQP03TNR16J02D						040	
	LQP03TNR18H02D					000	790	70
	LQP03TNR18J02D						790	
	LQP03TNR20H02D					500	750	
	LQP03TNR20J02D	200					730	
	LQP03TNR22H02D	220			13	300	710	
	LQP03TNR22J02D	220					710	
	LQP03TNR24H02D	240					630	60
	LQP03TNR24J02D	240				450	030	
	LQP03TNR27H02D	270			15		580	
	LQP03TNR27J02D	210					500	

^{*} Typical value is actual performance.

4. Testing Conditions

《Unless otherwise specified》

Temperature : Ordinary Temperature / 15°C to 35°C

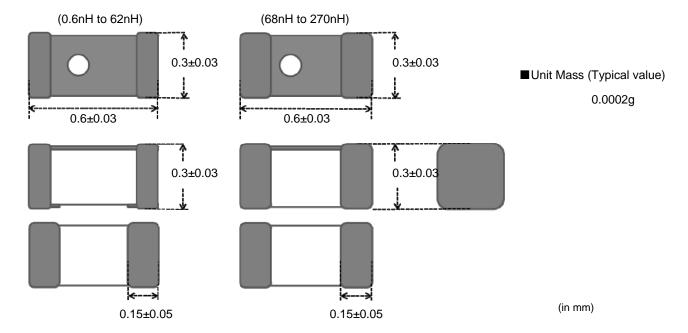
Humidity: Ordinary Humidity / 25%(RH) to 85 %(RH)

《In case of doubt》

Temperature : 20°C ± 2°C

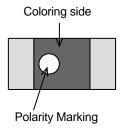
Humidity : 60%(RH) to 70 %(RH)
Atmospheric Pressure : 86kPa to 106 kPa

5. Appearance and Dimensions



6. Marking

Polarity Marking :white



7. Electrical Performance

No.	Item	Specification	Test Method
7.1	Inductance	Inductance shall meet item 3.	Measuring Equipment: KEYSIGHT E4991A or equivalent Measuring Frequency: (0.6nH~30nH) 500MHz (33nH~120nH) 300MHz (130nH~270nH) 100MHz Measuring Condition: Test signal level / about 0dBm Electrical length / 10mm Weight / about 1N to 5N Measuring Fixture: KEYSIGHT 16197A Position coil under test as shown in below and contact coil with each terminal by adding weight. Coloring side should be a topside, and should be in the direction of
7.2	Q	Q shall meet item 3.	the fixture for position of chip coil. The polarity Marking Measuring Method:See P.12 <electrical inductance="" method="" of="" performance:measuring="" q=""></electrical>
7.3	DC Resistance	DC Resistance shall meet item 3.	Measuring Equipment:Digital multi meter
7.4	Self Resonant Frequency(S.R.F)	S.R.F shall meet item 3.	Measuring Equipment: KEYSIGHT N5230A or equivalent
7.5	Rated Current	Self temperature rise shall be limited to 25°C max.	The rated current is applied.



8.Mechanical Performance

No.	Item	Specification	Test Method
8.1	Shear Test	Chip coil shall not be damaged	Substrate:Glass-epoxy substrate
		after tested as test method.	Land
			0.3
			0.9 (in mm)
			Force:2N
			Hold Duration:5 s±1 s
			Applied Direction: Parallel to PCB. Chip coil —
			F
			Substrate —//
8.2	Bending Test	Chip coil shall not be damaged	Substrate:Glass-epoxy substrate
		after tested as test method.	(100mm × 40mm × 0.8mm)
			Speed of Applying Force:1mm /s
			Deflection:1mm Hold Duration:30 s
			Pressure jig
			R340) \ F
			Deflection
			\cup
			45 45 Product (in mm)
8.3	Vibration	Appearance:No damage	Substrate:Glass-epoxy substrate
		Inductance Change: within ±10%	Oscillation Frequency:
			10Hz to 2000Hz to 10Hz for 20 min
			Total amplitude 1.5 mm or Acceleration
			amplitude 196 m/s ² whichever is smaller.
			Testing Time: A period of 2h in each of
			3 mutually perpendicular directions.
8.4	Solderability	The electrode shall be at least 90%	Flux: Ethanol solution of rosin 25(wt)%
]		covered with new solder coating.	(Immersed for 5s to 10s)
			Solder:Sn-3.0Ag-0.5Cu
			Pre-Heating:150°C±10°C / 60s to 90s
			Solder Temperature:240°C±5°C
8.5	Resistance to	Appearance:No damage	Immersion Time:3s±1s Flux: Ethanol solution of rosin 25(wt)%
0.5	Soldering Heat	Inductance Change: within ±10%	(Immersed for 5s to 10s)
			Solder:Sn-3.0Ag-0.5Cu
			Pre-Heating:150°C±10°C / 60s to 90s
			Solder Temperature:260°C±5°C
			Immersion Time:5s±1s
			Then measured after exposure in the room
		1	condition for 24h±2h.



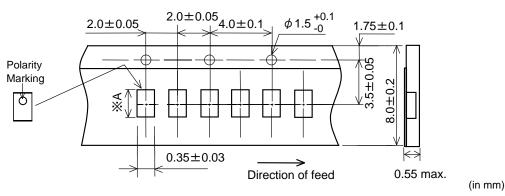
9. Environmental Performance

It shall be soldered on the substrate.

No.	Item	Specification	Test Method
9.1	Heat Resistance	Appearance:No damage	Substrate:Glass-epoxy substrate
		Inductance Change: within ±10%	Temperature:125°C
			Time:1000h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.2	Cold Resistance		Substrate:Glass-epoxy substrate
			Temperature:-55°C
			Time:1000 h (+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.3	Humidity		Substrate:Glass-epoxy substrate
			Temperature:40°C±2°C
			Humidity:90%(RH) to 95%(RH)
			Time:1000 h(+48h,-0h)
			Then measured after exposure in the
			room condition for 24h±2h.
9.4	Temperature		Substrate:Glass-epoxy substrate
	Cycle		1 cycle:
			1 step: -55°C / 30min±3 min
			2 step:Ordinary temp. / 10~15 min
			3 step: 125°C / 30min±3 min
			4 step: Ordinary temp. / 10~15 min
			Total of 10 cycles
			Then measured after exposure in the
			room condition for 24h±2h.

10. Specification of Packaging

10.1 Appearance and Dimensions of paper tape (8mm-wide)



*A 0N6~62N、R13~R27; 0.67±0.03 68N~R12; 0.65±0.03

10.2 Specification of Taping

(1) Packing quantity (standard quantity)

15,000 pcs. / reel

(2) Packing Method

Products shall be packed in the cavity of the base tape and sealed by cover tape.

(3) Sprocket hole

The sprocket holes are to the right as the tape is pulled toward the user.

(4) Spliced point

Base tape and Cover tape has no spliced point.

(5) Missing components number

Missing components number within 0.1 % of the number per reel or 1 pc., whichever is greater, and are not continuous. The Specified quantity per reel is kept.

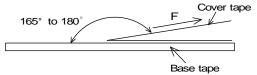


10.3 Pull Strength

Cover tape	5N min
oover tape	011111111

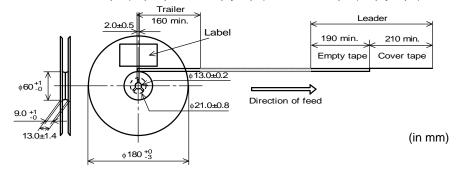
10.4 Peeling off force of cover tape

Speed of Peeling off	300mm/min
Dooling off force	0.1N to 0.6N
Peeling off force	(minimum value is typical)



10.5 Dimensions of Leader-tape, Trailer and Reel

There shall be leader-tape (top tape and empty tape) and trailer-tape (empty tape) as follows.



10.6 Marking for reel

Customer part number, MURATA part number, Inspection number(*1) , RoHS Marking (*2), Quantity etc \cdots

*1) < Expression of Inspection No.>

 $\frac{\square \square}{(1)} \quad \frac{OOOO}{(2)} \quad \frac{\times \times \times}{(3)}$

- (1) Factory Code
- (2) Date First digit : Year / Last digit of year

Second digit : Month / Jan. to Sep. \rightarrow 1 to 9, Oct. to Dec. \rightarrow O,N,D

Third, Fourth digit: Day

- (3) Serial No.
- *2) <Expression of RoHS Marking>

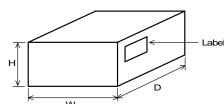
ROHS – \underline{Y} ($\underline{\Delta}$)

- (1) RoHS regulation conformity parts.
- (2) MURATA classification number

10.7 Marking for Outside package (corrugated paper box)

Customer name, Purchasing order number, Customer part number, MURATA part number, RoHS Marking (*2) ,Quantity, etc \cdots

10.8 Specification of Outer Case



Outer	Case Dim (mm)	ensions	Standard Reel Quantity in Outer Case (Reel)
W	V D H	Н	in Outer Case (Reei)
186	6 186		5

* Above Outer Case size is typical. It depends on a quantity of an order.



11. /\text{\text{Caution}}

Limitation of Applications

Please contact us before using our products for the applications listed below which require especially high reliability for the prevention of defects which might directly cause damage to the third party's life, body or property.

- (1) Aircraft equipment
- (2) Aerospace equipment
- (3) Undersea equipment
- (4) Power plant control equipment
- (5) Medical equipment
- (6) Transportation equipment (vehicles, trains, ships, etc.)
- (7) Traffic signal equipment
- (8) Disaster prevention / crime prevention equipment
- (9) Data-processing equipment
- (10) Applications of similar complexity and /or reliability requirements to the applications listed in the above

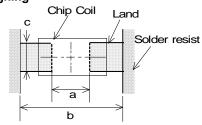
12. Notice

Products can only be soldered with reflow.

This product is designed for solder mounting.

Please consult us in advance for applying other mounting method such as conductive adhesive.

12.1 Land pattern designing



		_,
а	0.2~0.3	
b	0.8~0.9	
С	0.2~0.3	
		(in mm)

12.2 Flux, Solder

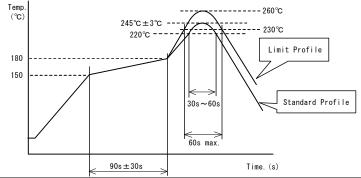
· Use rosin-based flux.

Don't use highly acidic flux with halide content exceeding 0.2(wt)% (chlorine conversion value). Don't use water-soluble flux.

- · Use Sn-3.0Ag-0.5Cu solder.
- Standard thickness of solder paste : $100 \,\mu$ m~ $150 \,\mu$ m.

12.3 Reflow soldering conditions

- Pre-heating should be in such a way that the temperature difference between solder and product surface is limited to 150°C max. Cooling into solvent after soldering also should be in such a way that the temperature difference is limited to 100°C max.
 Insufficient pre-heating may cause cracks on the product, resulting in the deterioration of products quality.
- Standard soldering profile and the limit soldering profile is as follows.
 The excessive limit soldering conditions may cause leaching of the electrode and / or resulting in the deterioration of product quality.
- · Reflow soldering profile



	Standard Profile	Limit Profile
Pre-heating	150°C~180°C 、90s±30s	
Heating	above 220°C, 30s∼60s	above 230°C, 60s max.
Peak temperature	245°C±3°C	260°C,10s
Cycle of reflow	2 times	2 times



12.4 Reworking with soldering iron

The following conditions must be strictly followed when using a soldering iron.

Pre-heating	150°C,1 min
Tip temperature	350°C max.
Soldering iron output	80W max.
Tip diameter	ϕ 3mm max.
Soldering time	3(+1,-0)s
Time	2 times

Note: Do not directly touch the products with the tip of the soldering iron in order to prevent the crack on the products due to the thermal shock.

12.5 Solder Volume

· Solder shall be used not to be exceeded the upper limits as shown below.

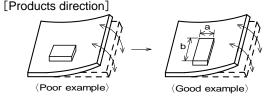


Accordingly increasing the solder volume, the mechanical stress to Chip is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance.

12.6 Attention regarding P.C.B. bending

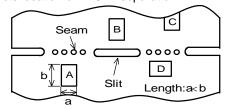
The following shall be considered when designing and laying out P.C.B.'s.

(1) P.C.B. shall be designed so that products are not subject to the mechanical stress due to warping the board.



Products shall be located in the sideways direction (Length:a < b) to the mechanical stress.

(2) Products location on P.C.B. separation



Products (A,B,C,D) shall be located carefully so that products are not subject to the mechanical stress due to warping the board. Because they may be subjected the mechanical stress in order of $A>C>B \cong D$.

12.7 Cleaning Conditions

Products shall be cleaned on the following conditions.

- (1) Cleaning temperature shall be limited to 60°C max.(40°C max for IPA)
- (2) Ultrasonic cleaning shall comply with the following conditions with avoiding the resonance phenomenon at the mounted products and P.C.B.

Power: 20 W / I max. Frequency: 28kHz to 40kHz Time: 5 min max.

- (3) Cleaner
 - Alcohol type cleaner Isopropyl alcohol (IPA)
 - 2. Aqueous agent PINE ALPHA ST-100S
- (4) There shall be no residual flux and residual cleaner after cleaning. In the case of using aqueous agent, products shall be dried completely after rinse with de-ionized water in order to remove the cleaner.
- (5) Other cleaning Please contact us.



12.8 Resin coating

When products are coated with resin, please contact us in advance.

12.9 Handling of a substrate

(1)There is a possibility of chip cracking caused by PCBexpansion/contraction with heat, because stress on a chip is different depending on PCB material and structure.

When the thermal expansion coefficient greatly differs between the board used for mounting and the chip, it will cause cracking of the chip due to the thermal expansion and contraction.

The chip is assumed to be mounted on the PCB of glass-epoxy material, and we don't test with other PCB material which has different thermal expansion coefficient from Glass-epoxy.

When other PCB materials are considered, please be sure to evaluate by yourself.

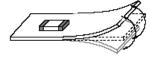
(2) After mounting products on a substrate, do not apply any stress to the product caused by bending or twisting to the substrate when cropping the substrate, inserting and removing a connector from the substrate or tightening screw to the substrate.

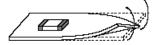
Excessive mechanical stress may cause cracking in the product.

In case of the mounting on flexible PCB, there is a possibility of chip cracking caused by mechanical stress even from small bending or twisting.

When the flexible PCB is considered, please be sure to evaluate by yourself.

Bending Twisting





12.10 Storage and Handing Requirements

(1) Storage period

Use the products within 12 months after delivered. Solderability should be checked if this period is exceeded.

- (2) Storage conditions
 - Products should be stored in the warehouse on the following conditions.

Temperature : -10°C ~ 40°C

Humidity : 15% to 85% relative humidity No rapid change on temperature and humidity.

- Products should not be stored on bulk packaging condition to prevent the chipping of the core and the breaking of winding wire caused by the collision between the products.
- Products should be stored on the palette for the prevention of the influence from humidity, dust and so on.
- Products should be stored in the warehouse without heat shock, vibration, direct sunlight and so on.
- (3) Handling Condition

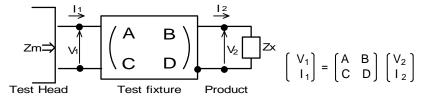
Care should be taken when transporting or handling product to avoid excessive vibration or mechanical shock.

13. 1 Note

- (1)Please make sure that your product has been evaluated in view of your specifications with our product being mounted to your product.
- (2)You are requested not to use our product deviating from the reference specifications.
- (3)The contents of this reference specification are subject to change without advance notice. Please approve our product specifications or transact the approval sheet for product specifications before ordering.

-<Electrical Performance:Measuring Method of Inductance/Q>

(1) Residual elements and stray elements of test fixture can be described by F-parameter shown in following.



(2) The impedance of chip coil Zx and measured value Zm can be described by input/output current/voltage.

$$Zm = \frac{V_1}{I_1} \qquad Zx = \frac{V_2}{I_2}$$

(3) Thus, the relation between Zx and Zm is following;

$$Zx = \alpha \frac{Zm - \beta}{1 - Zm \Gamma}$$
 where, $\alpha = D / A = 1$
 $\beta = B / D = Zsm - (1 - Yom Zsm)Zss$
 $\Gamma = C / A = Yom$

Zsm:measured impedance of short chip
Zss:residual impedance of short chip (0.480nH)
Yom:measured admittance when opening the fixture

(4) Lx and Qx shall be calculated with the following equation.

$$x = \frac{Im(Zx)}{2\pi f}$$
, $Qx = \frac{Im(Zx)}{Re(Zx)}$ Lx :Inductance of chip coil $Qx:Q$ of chip coil f :Measuring frequency

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Fixed Inductors category:

Click to view products by Murata manufacturer:

Other Similar products are found below:

MLZ1608M6R8WTD25 MLZ1608N6R8LT000 MLZ1608N3R3LTD25 MLZ1608N3R3LTD00 MLZ1608N150LT000 MLZ1608N150WTD05 MLZ1608M3R3WTD25 MLZ1608M3R3WT000 MLZ1608M150WT000 MLZ1608A1R5WT000 MLZ1608N1R5LT000 B82432C1333K000 PCMB053T-1R0MS PCMB053T-1R5MS PCMB104T-1R5MS CR32NP-100KC CR32NP-151KC CR32NP-180KC CR32NP-181KC CR32NP-1R5MC CR32NP-390KC CR32NP-390KC CR32NP-389MC CR32NP-680KC CR32NP-820KC CR32NP-8R2MC CR43NP-390KC CR43NP-560KC CR43NP-680KC CR54NP-181KC CR54NP-470LC CR54NP-820KC CR54NP-8R5MC MGDQ4-00004-P MGDU1-00016-P MHL1ECTTP18NJ MHL1JCTTD12NJ PE-51506NL PE-53601NL PE-53630NL PE-53824SNLT PE-62892NL PE-92100NL PG0434.801NLT PG0936.113NLT PM06-2N7 PM06-39NJ HC2LP-R47-R HC2-R47-R HC3-2R2-R HC8-1R2-R